

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10576579	YOON ET AL.
Examiner	Art Unit	
Long Pham	2814	

SEARCHED

Class	Subclass	Date	Examiner
257	310, 192	03/31/08	LP

SEARCH NOTES

Search Notes	Date	Examiner
Updated text or interference searches	03/31/08	LP

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
257	310	03/31/08	LP